

Search Notes

Application/Control No.

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Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

WU ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	262	6/13/2007	EMF
375	316	6/13/2007	
375	340	6/13/2007	
375	341	6/13/2007	
714	286	6/13/2007	
714	794	6/13/2007	
714	795	6/13/2007	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB Keyword Search--See Search Printout History		6/13/2007	EMF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	6/13/2007	EMF
PALM INVENTORSHIP	6/13/2007	EMF
IEEE Advanced Keyword Search--See Search Printout History	6/13/2007	EMF